

Modular RICH Simulation -Delta Ray Electron

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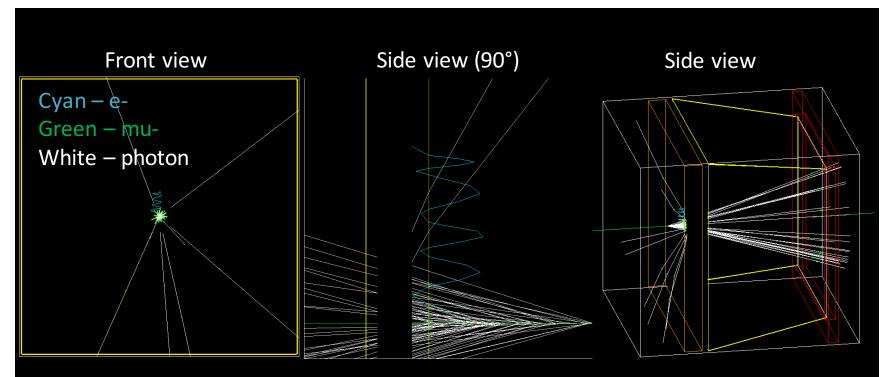


Simulation Setup

- Single Muon, 20GeV
- Aerogel
 - 1 cm thick
 - Refractive index=1.05
- Magnetic field
 - $-(B_x, B_y, B_z)=(0, 1.5, 0)T$
- Hit type = eic_rich



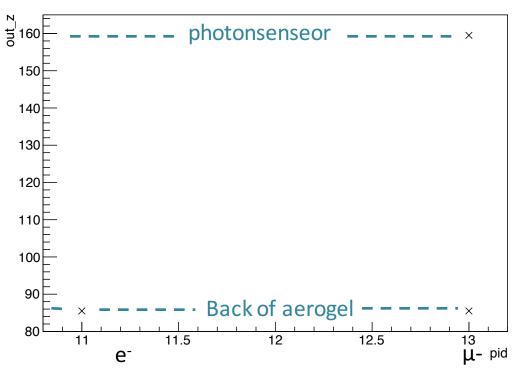
Event Display

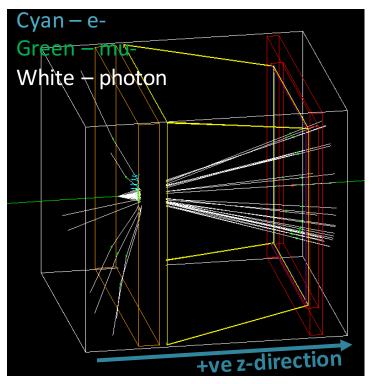


- An electron has been ionized. It passes through the back of aerogel several times
- Fresnel lens holder is blackened for better visualization



z-position of Hits (Non-Photon)



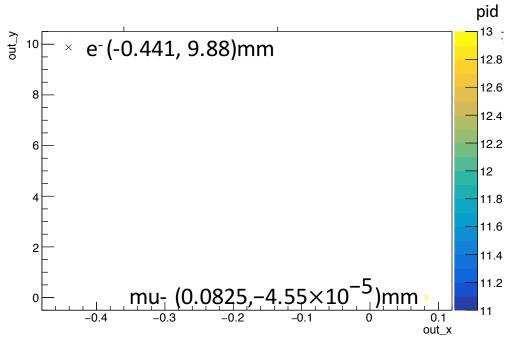


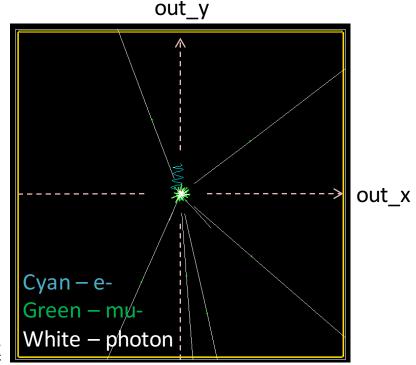
Z-Position of Hits vs. PID

- Two entries of muon hits
 - At the back of aerogel
 - photonsensor
- One entry of delta ray e-
 - At the back of aerogel

Hit Position at the Back of Aerogel (Non-Photon)



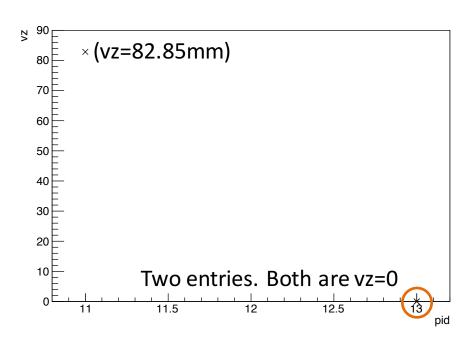




Hit Position at the back of aerogel: out_y VS. out_x

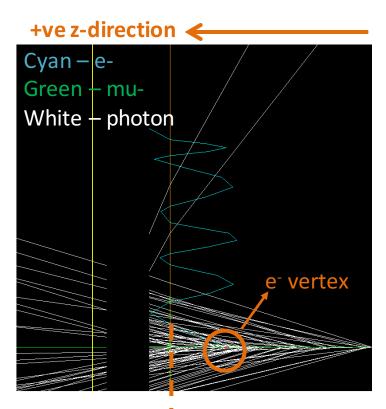
- mu- hit is close to the origin of x-y plane
- E- hit is at a higher y-position which mataches the event display (shown on the right)

Z-position of Vertex (non-photon)



<u>Vertex of delta ray electron – Vz VS. PID</u>

- Two entries of vertex position are recorded for muon. Both are at vz=0 which is the launching position of muon
- One entry of e- vertex position are recorded



The back of the aerogel



Summary

- A single particle can create more than one hits with different hit positions (out_z)
- However, there will be redundant record of vertex (vz)

→Hit position cut is needed to reduced double count



Next

- What if the particle re-enter the aerogel?
 - Extra out_z recorded?